PD-95769

# International

- Advanced Process Technology
- Surface Mount (IRF9Z34NS)
- Low-profile through-hole (IRF9Z34NL)
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead-Free

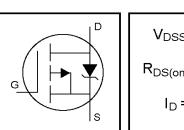
#### Description

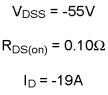
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

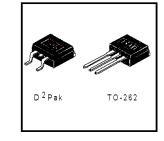
The D<sup>2</sup>Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRF9Z34NL) is available for lowprofile applications.

#### **Absolute Maximum Ratings**







IRF9Z34NSPbF

IRF9Z34NLPbF

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>(5)</sup>	-19	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>®</sup>	-14	A
I <sub>DM</sub>	Pulsed Drain Current 00	-68	
$P_D@T_A = 25^{\circ}C$	Power Dissipation	3.8	W
P <sub>D</sub> @T <sub>C</sub> =25°C	Power Dissipation	68	W
	Linear Derating Factor	0.45	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy 25	180	mJ
I <sub>AR</sub>	Avalanche Current®	-10	A
E <sub>AR</sub>	Repetitive Avalanche Energy <sup>①</sup>	6.8	mJ
dv/dt	Peak Diode Recovery dv/dt 35	-5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

#### Thermal Resistance

	Parameter	Тур.	Max.	Units
Rejc	Junction-to-Case		2.2	0000
R <sub>eja</sub>	Junction-to-Ambient (PCB Mounted,steady-state)**		40	°CW

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#### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	-55			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250µA	
ΔV(BR)DSS/ΔTJ	Breakdown Voltage Temp. Coefficient		-0.05		V/°C	Reference to 25°C, $I_D = -1$ mA $\odot$	
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.10	Ω	V <sub>GS</sub> = -10V, I <sub>D</sub> = -10A ④	
VGS(th)	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
<b>g</b> fs	Forward Transconductance	4.2			S	V <sub>DS</sub> = -25V, I <sub>D</sub> = -10A <sup>(</sup>	
[	Desire to Courses Looks and Current			-25	μA	$V_{DS} = -55V, V_{GS} = 0V$	
DSS	Drain-to-Source Leakage Current		·	-250	μΑ	$V_{DS}$ = -44V, $V_{GS}$ = 0V, $T_{J}$ = 150°C	
1	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V	
GSS	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V	
Qg	Total Gate Charge			35		I <sub>D</sub> = -10A	
Q <sub>gs</sub>	Gate-to-Source Charge			7.9	nC	V <sub>DS</sub> = -44V V <sub>GS</sub> = -10V, See Fig. 6 and 13 ④⑤	
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge			16			
t <sub>d(on)</sub>	Turn-On Delay Time		13			V <sub>DD</sub> = -28V	
tr	RiseTime		55			$I_D = -10A$ $R_G = 13\Omega$ $R_D = 2.6\Omega$ , See Fig. 10 @	
t <sub>d(off)</sub>	Turn-Off Delay Time	-	30		ns		
t <sub>f</sub>	Fall Time		41				
L <sub>S</sub>	Internal Source Inductance		7.5	-	nH	Between lead, and center of die contact	
Ciss	Input Capacitance		620			V <sub>GS</sub> = 0V	
Coss	Output Capacitance		280		pF	V <sub>DS</sub> = -25V <i>f</i> = 1.0MHz, See Fig. 5©	
Crss	Reverse Transfer Capacitance		140				

#### **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current (Body Diode)		-	-19	A	MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①		_	-68		integral reverse p-n junction diode.
VSD	Diode Forward Voltage			-1.6	V	$T_{J} = 25^{\circ}C, I_{S} = -10A, V_{GS} = 0V$ (9)
trr	Reverse Recovery Time		54	82	ns	TJ = 25°C, IF = -10A
Qrr	Reverse Recovery Charge		110	160	nC	di/dt = -100A/µs ⊛⑤
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

#### Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11) ④ Pulse width  $\leq$  300µs; duty cycle  $\leq$  2%.

② Starting  $T_J = 25^{\circ}C$ , L = 3.6mH

⑤ Uses IRF9Z34N data and test conditions

 $R_{G}$  = 25  $\Omega$ ,  $I_{AS}$  = -10A. (See Figure 12)

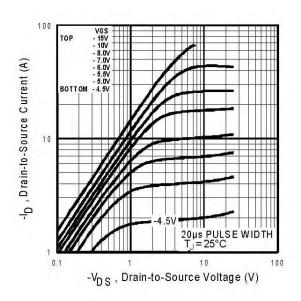
 $\label{eq:ISD} \textcircled{3} I_{\text{SD}} \leq \textbf{-10A}, \ \textbf{di/dt} \leq \textbf{-290A/\mus}, \ V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}},$  $T_J \leq 175^\circ C$ 

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material ).

For recommended footprint and soldering techniques refer to application note #AN-994.

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IRF9Z34NS/LPbF





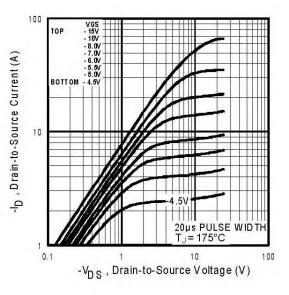


Fig 2. Typical Output Characteristics

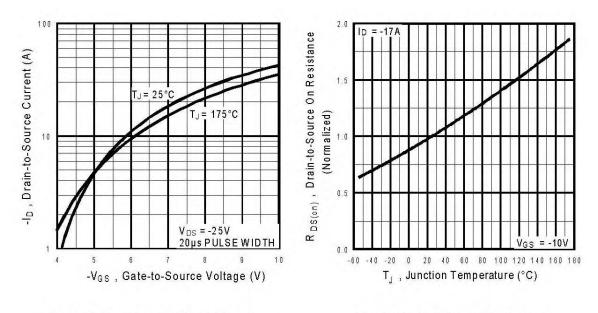


Fig 3. Typical Transfer Characteristics





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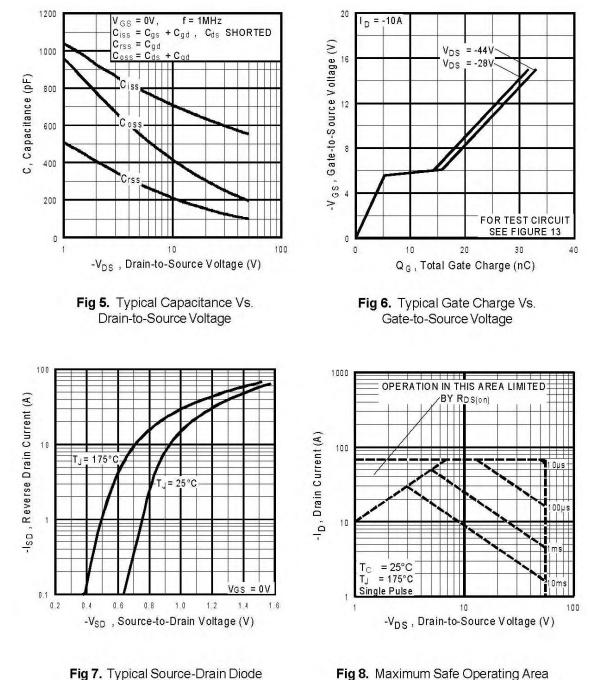


Fig 8. Maximum Safe Operating Area

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Forward Voltage

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### IRF9Z34NS/LPbF

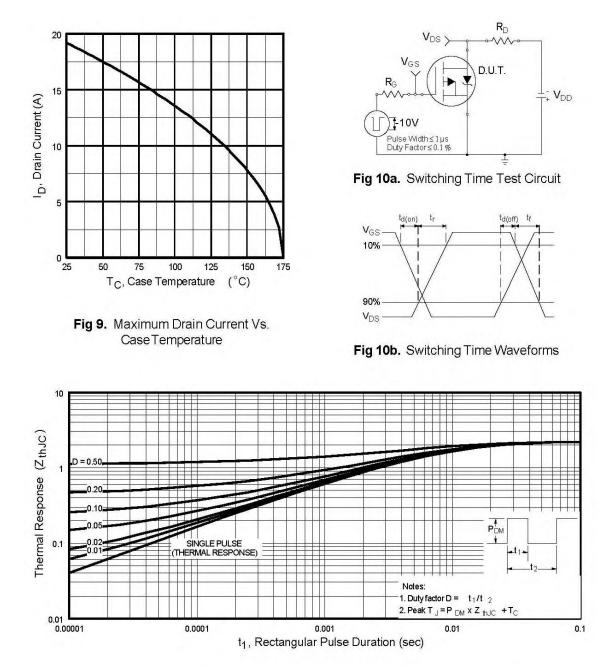


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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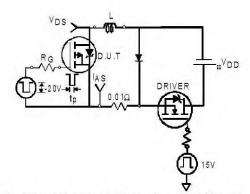


Fig 12a. Unclamped Inductive Test Circuit

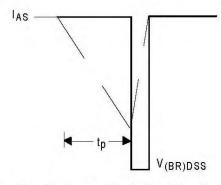


Fig 12b. Unclamped Inductive Waveforms

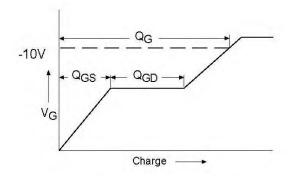


Fig 13a. Basic Gate Charge Waveform

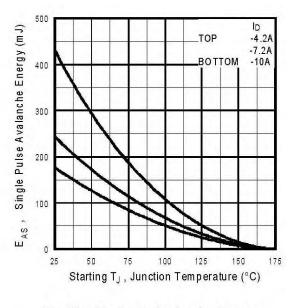


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

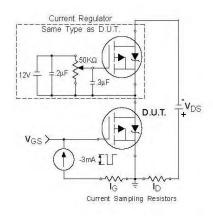
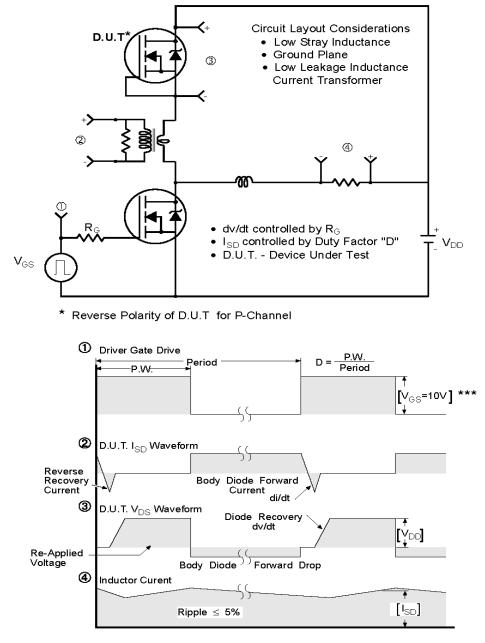


Fig 13b. Gate Charge Test Circuit

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### IRF9Z34NS/LPbF

#### Peak Diode Recovery dv/dt Test Circuit



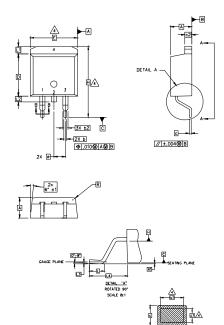
\*\*\*  $V_{\rm GS}$  = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

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### $D^2Pak$ Package Outline (Dimensions are shown in millimeters (inches)

NOTES:



_	5. CONTROLLING DIMENSION: INCH.							
	S Y DIMENSIONS							
	B	MILLIMETERS			INC	0 T E S		
	0 L	MIN.	MAX.	I	MIN.	MAX.	E S	
	Α	4,06	4.83	ľ	,160	.190		
	A1	0.00	0.254		.000	.010		
	ь	0.51	0.99		.020	.039		
	b1	0.51	0.89		.020	.035	4	
	b2	1,14	1,78		.045	.070		
	с	0.38	0.74		.015	.029		
	c1	0.38	0.58		.015	.023	4	
	c2	1.14	1.65		.045	.065		
	D	8.51	9.65		.335	.380	3	
	D1	6,86			.270			
	Е	9.65	10.67		.380	.420	3	
	E1	6.22			.245			
	е	2.54	BSC		.100			
	н	14.61	15.88	Í	.575	.625		
	L	1.78	2.79		.070	,110		
	L1		1.65			.065		
	L2	1.27	1.78	l	.050	.070		
	L3	0.25	BSC	l	.010			
	L4	4,78	5.28		,188	.208		
	m	17.78			.700			
	m1	8,89			.350			
	n	11.43			.450			
	0	2.08			.082			
	Ρ	3.81			.150			
	R	0.51	0.71		.020	.028		
	θ	90"	93.	1	90	93*		
L				Ц				

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

3. DIMENSION D & E DO NOT INCLUDE WOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

A. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

#### LEAD ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.4.- DRAIN 3.- SOURCE

IGBTS. COPACK 1.- GATE 2. 4.- COLLECTOR 3.- EMITTER

#### DIODES 1.- ANODE \* 2, 4.- CATHODE 3.- ANODE

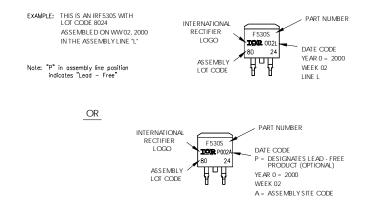
\* PART DEPENDENT.

### D<sup>2</sup>Pak Part Marking Information

 SECTION B-B

Π

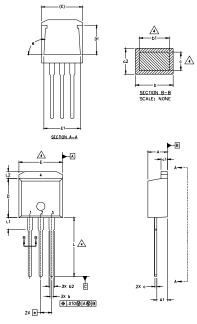
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# International **ISPR** Rectifier

### IRF9Z34NS/LPbF

### TO-262 Package Outline (Dimensions are shown in millimeters (inches)



S Y M	DIMENSIONS						
B	MILLIM	ETERS	INC	O T E S			
B O L	MIN.	MAX.	MIN.	MAX.	E S		
А	4.06	4.83	.160	.190			
A1	2.03	2.92	.080	.115			
b	0.51	0.99	.020	.039			
b1	0.51	0.89	.020	.035	4		
b2	1.14	1.40	.045	.055			
С	0.38	0.63	.015	.025	4		
c1	1.14	1.40	.045	.055			
c2	0.43	.063	.017	.029			
D	8.51	9.65	.335	.380	3		
D1	5.33		.210				
Е	9.65	10.67	.380	.420	3		
E1	6.22		.245				
е	2.54 BSC		.100 BSC				
L	13,46	14.09	.530	.555			
L1	3.56	3.71	.140	.146			
L2		1.65		.065			

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE

2.- DRAIN

4.- DRAIN

3.- SOURCE

<u>IGBT</u>

2 - COLLECTOR

3 - EMITTER

1 - GATE

#### (\_\_\_\_\_

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

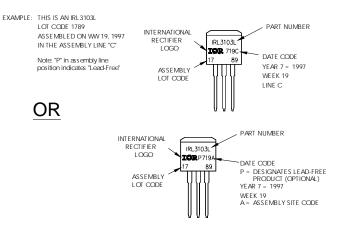
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3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

ADIMENSION 61 AND C1 APPLY TO BASE METAL ONLY.

5. CONTROLLING DIMENSION: INCH.

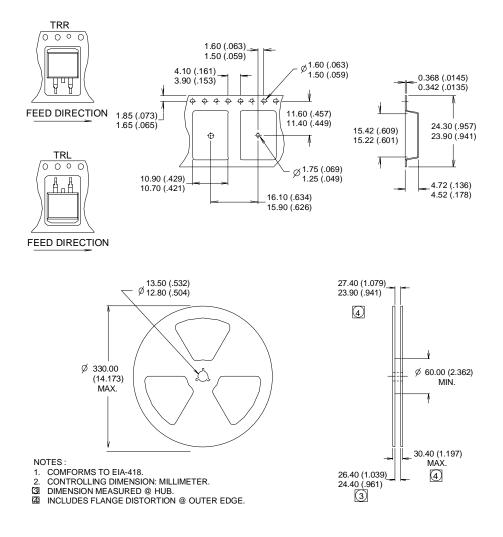
### TO-262 Part Marking Information



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### D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



Data and specifications subject to change without notice.

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